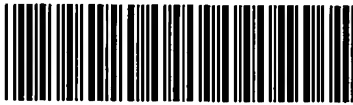


Search Notes

Application/Control No.

10/529,225

Examiner

James A. Dudek

Applicant(s)/Patent under
Reexamination

TANAKA ET AL.

Art Unit

2871

SEARCHED

Class	Subclass	Date	Examiner
349	114,15	10/24/2006	JAD

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR